

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/698,665	QUMEI ET AL.	
Examiner	Art Unit	
Philip Wang	2191	

	SEARCHED		
Class	Subclass	Date	Examiner
717	168-178	3/30/2007	PW
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Plus	3/27/2007	PW		
east	3/29/2007	PW		
NPL	3/30/2007	PW		
Google	3/29/2007	PW		
consulted with Gail Hayes on joint inventor issue	4/2/2007	PW		